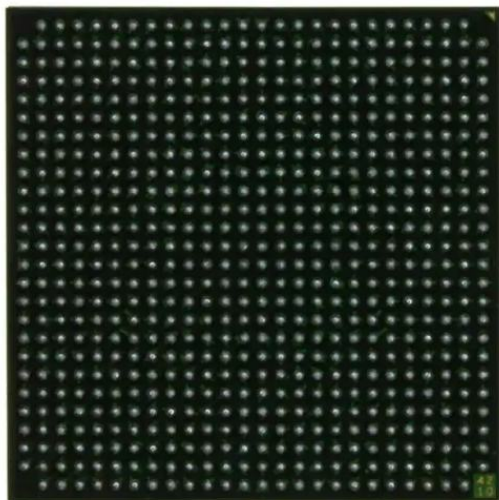




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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

Details

Product Status	Obsolete
Number of LABs/CLBs	752
Number of Logic Elements/Cells	6768
Total RAM Bits	516096
Number of I/O	348
Number of Gates	-
Voltage - Supply	1.425V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	672-BBGA, FCBGA
Supplier Device Package	672-FCBGA (27x27)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc2vp4-6ffg672c

The Trace port provides instruction execution trace information to an external trace tool. The PPC405 core is capable of back trace and forward trace. Back trace is the tracing of instructions prior to a debug event while forward trace is the tracing of instructions after a debug event.

The processor JTAG port and the FPGA JTAG port can be accessed independently, or the two can be programmatically linked together and accessed via the dedicated FPGA JTAG pins.

For detailed information on the PPC405 JTAG interface, please refer to the "JTAG Interface" section of the [PowerPC 405 Processor Block Reference Guide](#)

CoreConnect™ Bus Architecture

The Processor Block is compatible with the CoreConnect™ bus architecture. Any CoreConnect compliant cores including Xilinx soft IP can integrate with the Processor Block through this high-performance bus architecture implemented on FPGA fabric.

The CoreConnect architecture provides three buses for interconnecting Processor Blocks, Xilinx soft IP, third party IP, and custom logic, as shown in [Figure 15](#):

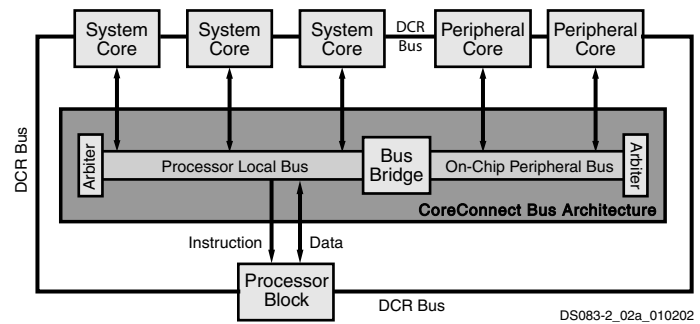


Figure 15: CoreConnect Block Diagram

- Processor Local Bus (PLB)
- On-Chip Peripheral Bus (OPB)
- Device Control Register (DCR) bus

High-performance peripherals connect to the high-bandwidth, low-latency PLB. Slower peripheral cores connect to the OPB, which reduces traffic on the PLB, resulting in greater overall system performance.

For more information, refer to:

http://www-3.ibm.com/chips/techlib/techlib.nfs/productfamiles/CoreConnect_Bus_Architecture/

Functional Description: Embedded PowerPC 405 Core

This section offers a brief overview of the various functional blocks shown in [Figure 16](#).

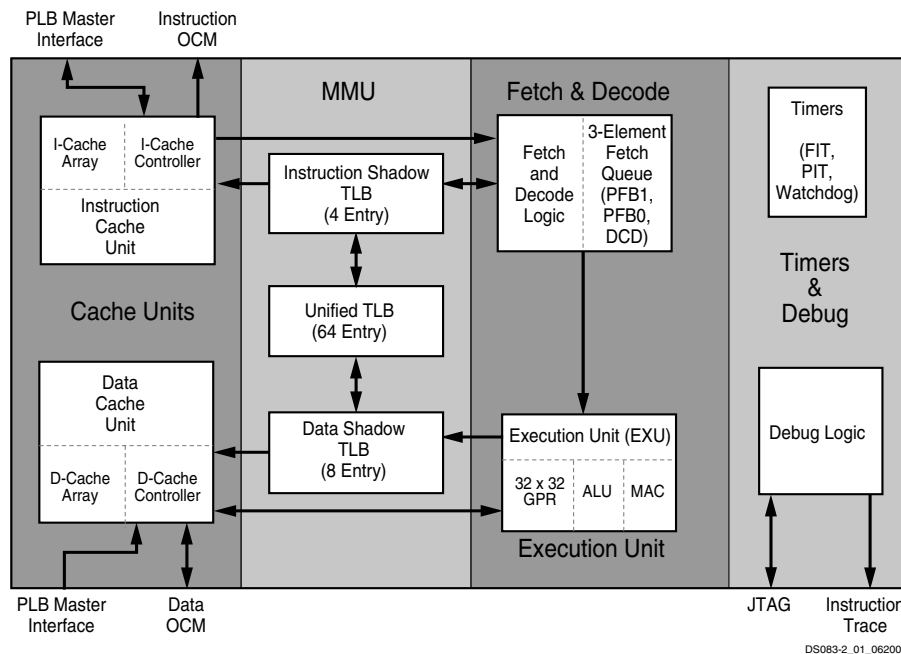


Figure 16: Embedded PPC405 Core Block Diagram

Embedded PPC405 Core

The embedded PPC405 core is a 32-bit Harvard architecture processor. [Figure 16](#) illustrates its functional blocks:

- Cache units
- Memory Management unit
- Fetch Decode unit

Table 11: LVCMOS Programmable Currents (Sink and Source)

SelectIO-Ultra	Programmable Current (Worst-Case Guaranteed Minimum)						
LVTTL	2 mA	4 mA	6 mA	8 mA	12 mA	16 mA	24 mA
LVCMOS33	2 mA	4 mA	6 mA	8 mA	12 mA	16 mA	24 mA
LVCMOS25	2 mA	4 mA	6 mA	8 mA	12 mA	16 mA	24 mA
LVCMOS18	2 mA	4 mA	6 mA	8 mA	12 mA	16 mA	n/a
LVCMOS15	2 mA	4 mA	6 mA	8 mA	12 mA	16 mA	n/a

Figure 23 shows the SSTL2, SSTL18, and HSTL configurations. HSTL can sink current up to 48 mA. (HSTL IV)

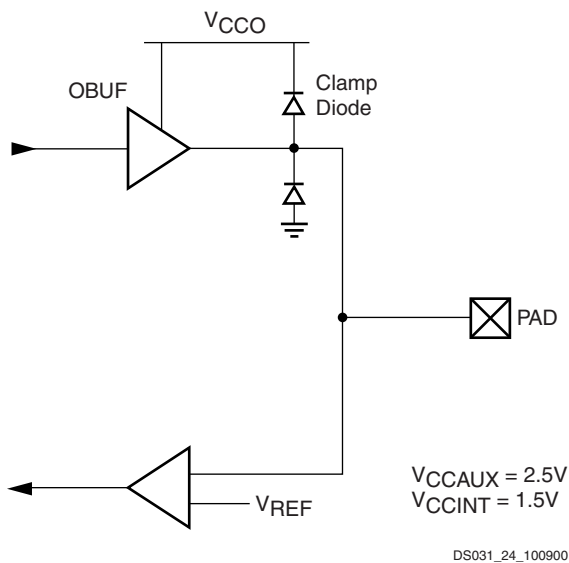


Figure 23: SSTL or HSTL SelectIO-Ultra Standards

All pads are protected against damage from electrostatic discharge (ESD) and from over-voltage transients. Virtex-II Pro uses two memory cells to control the configuration of an I/O as an input. This is to reduce the probability of an I/O configured as an input from flipping to an output when subjected to a single event upset (SEU) in space applications.

Prior to configuration, all outputs not involved in configuration are forced into their high-impedance state. The pull-down resistors and the weak-keeper circuits are inactive. The dedicated pin HSWAP_EN controls the pull-up resistors prior to configuration. By default, HSWAP_EN is set High, which disables the pull-up resistors on user I/O pins. When HSWAP_EN is set Low, the pull-up resistors are activated on user I/O pins.

All Virtex-II Pro IOBs (except RocketIO transceiver pins) support IEEE 1149.1 and IEEE 1532 compatible Boundary-Scan testing.

Input Path

The Virtex-II Pro IOB input path routes input signals directly to internal logic and / or through an optional input flip-flop or latch, or through the DDR input registers. An optional delay element at the D-input of the storage element eliminates pad-to-pad hold time. The delay is matched to the internal clock-distribution delay of the Virtex-II Pro device, and when used, assures that the pad-to-pad hold time is zero.

Each input buffer can be configured to conform to any of the low-voltage signaling standards supported. In some of these standards the input buffer utilizes a user-supplied threshold voltage, V_{REF} . The need to supply V_{REF} imposes constraints on which standards can be used in the same bank. See I/O banking description.

Output Path

The output path includes a 3-state output buffer that drives the output signal onto the pad. The output and / or the 3-state signal can be routed to the buffer directly from the internal logic or through an output / 3-state flip-flop or latch, or through the DDR output / 3-state registers.

Each output driver can be individually programmed for a wide range of low-voltage signaling standards. In most signaling standards, the output High voltage depends on an externally supplied V_{CCO} voltage. The need to supply V_{CCO} imposes constraints on which standards can be used in the same bank. See I/O banking description.

I/O Banking

Some of the I/O standards described above require V_{CCO} and V_{REF} voltages. These voltages are externally supplied and connected to device pins that serve groups of IOB blocks, called banks. Consequently, restrictions exist about which I/O standards can be combined within a given bank.

Eight I/O banks result from dividing each edge of the FPGA into two banks, as shown in Figure 24 and Figure 25. Each bank has multiple V_{CCO} pins, all of which must be connected to the same voltage. This voltage is determined by the output standards in use.

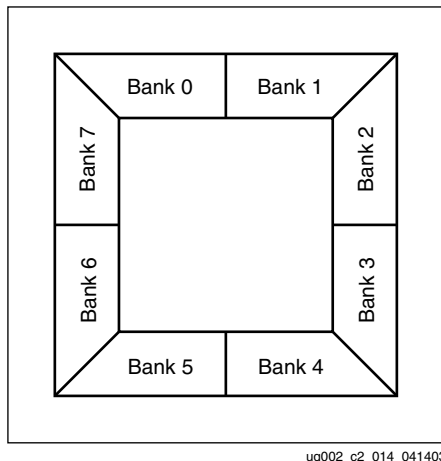


Figure 24: I/O Banks: Wire-Bond Packages (FG)
Top View

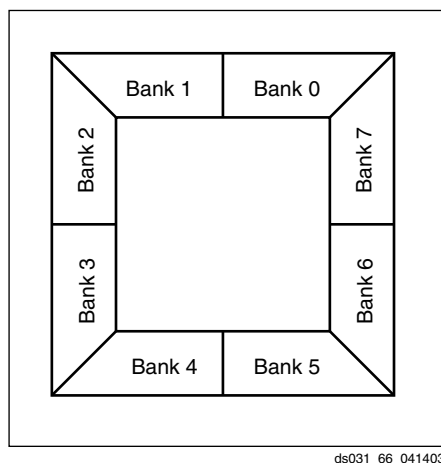


Figure 25: I/O Banks: Flip-Chip Packages (FF)
Top View

Some input standards require a user-supplied threshold voltage (V_{REF}), and certain user-I/O pins are automatically configured as V_{REF} inputs. Approximately one in six of the I/O pins in the bank assume this role.

V_{REF} pins within a bank are interconnected internally, thus only one V_{REF} voltage can be used within each bank. However, for correct operation, all V_{REF} pins in the bank must be connected to the external reference voltage source.

The V_{CCO} and the V_{REF} pins for each bank appear in the device pinout tables. Within a given package, the number of V_{REF} and V_{CCO} pins can vary depending on the size of device. In larger devices, more I/O pins convert to V_{REF} pins. Since these are always a superset of the V_{REF} pins used for smaller devices, it is possible to design a PCB that permits migration to a larger device if necessary.

All V_{REF} pins for the largest device anticipated must be connected to the V_{REF} voltage and not used for I/O. In smaller devices, some V_{CCO} pins used in larger devices do not con-

nect within the package. These unconnected pins can be left unconnected externally, or, if necessary, they can be connected to V_{CCO} to permit migration to a larger device.

Rules for Combining I/O Standards in the Same Bank

The following rules must be obeyed to combine different input, output, and bi-directional standards in the same bank:

1. **Combining output standards only.** Output standards with the same output V_{CCO} requirement can be combined in the same bank.

Compatible example:

SSTL2_I and LVDS_25 outputs

Incompatible example:

SSTL2_I (output $V_{CCO} = 2.5V$) and
LVCMOS33 (output $V_{CCO} = 3.3V$) outputs

2. **Combining input standards only.** Input standards with the same input V_{CCO} and input V_{REF} requirements can be combined in the same bank.

Compatible example:

LVCMOS15 and HSTL_IV inputs

Incompatible example:

LVCMOS15 (input $V_{CCO} = 1.5V$) and
LVCMOS18 (input $V_{CCO} = 1.8V$) inputs

Incompatible example:

HSTL_I_DCI_18 ($V_{REF} = 0.9V$) and
HSTL_IV_DCI_18 ($V_{REF} = 1.1V$) inputs

3. **Combining input standards and output standards.** Input standards and output standards with the same input V_{CCO} and output V_{CCO} requirement can be combined in the same bank.

Compatible example:

LVDS_25 output and HSTL_I input

Incompatible example:

LVDS_25 output (output $V_{CCO} = 2.5V$) and
HSTL_I_DCI_18 input (input $V_{CCO} = 1.8V$)

4. **Combining bi-directional standards with input or output standards.** When combining bi-directional I/O with other standards, make sure the bi-directional standard can meet rules 1 through 3 above.

5. **Additional rules for combining DCI I/O standards.**

- a. No more than one Single Termination type (input or output) is allowed in the same bank.

Incompatible example:

HSTL_IV_DCI input and HSTL_III_DCI input

- b. No more than one Split Termination type (input or output) is allowed in the same bank.

Incompatible example:

HSTL_I_DCI input and HSTL_II_DCI input

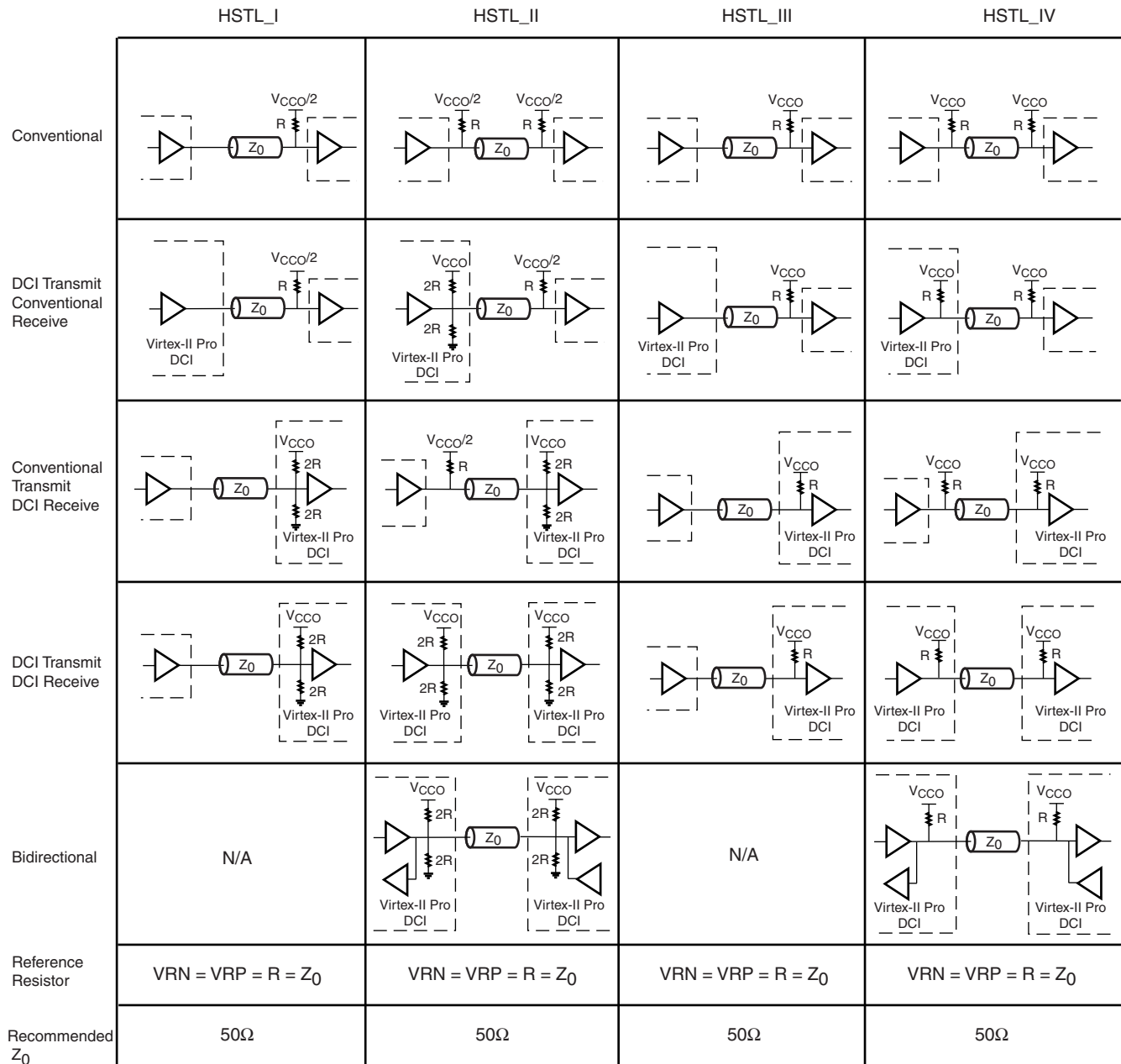
The implementation tools will enforce the above design rules.

Table 12, page 30, summarizes all standards and voltage supplies.

Table 15: SelectIO-Ultra Differential Buffers With On-Chip Termination

I/O Standard Description	IOSTANDARD Attribute	
	External Termination	On-Chip Termination
LVDS 2.5V	LVDS_25	LVDS_25_DCI
LVDS Extended 2.5V	LVDSEXT_25	LVDSEXT_25_DCI

Figure 28 provides examples illustrating the use of the HSTL_I_DCI, HSTL_II_DCI, HSTL_III_DCI, and HSTL_IV_DCI I/O standards. For a complete list, see the [Virtex-II Pro Platform FPGA User Guide](#).



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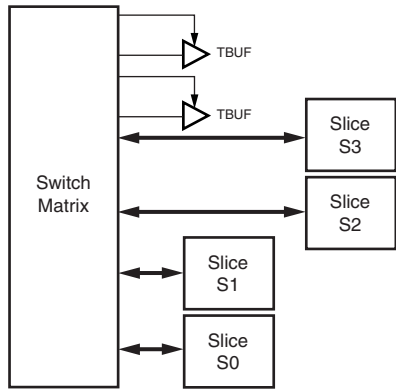
Figure 28: HSTL DCI Usage Examples

3-State Buffers

Introduction

Each Virtex-II Pro CLB contains two 3-state drivers (TBUFs) that can drive on-chip buses. Each 3-state buffer has its own 3-state control pin and its own input pin.

Each of the four slices have access to the two 3-state buffers through the switch matrix, as shown in Figure 45. TBUFs in neighboring CLBs can access slice outputs by direct connects. The outputs of the 3-state buffers drive horizontal routing resources used to implement 3-state buses.



DS031_37_060700

Figure 45: Virtex-II Pro 3-State Buffers

The 3-state buffer logic is implemented using AND-OR logic rather than 3-state drivers, so that timing is more predictable and less load dependant especially with larger devices.

Locations / Organization

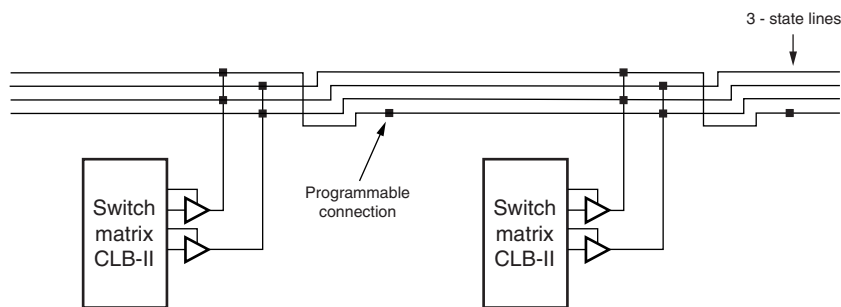
Four horizontal routing resources per CLB are provided for on-chip 3-state buses. Each 3-state buffer has access alternately to two horizontal lines, which can be partitioned as shown in Figure 46. The switch matrices corresponding to SelectRAM+ memory and multiplier or I/O blocks are skipped.

Number of 3-State Buffers

Table 18 shows the number of 3-state buffers available in each Virtex-II Pro device. The number of 3-state buffers is twice the number of CLB elements.

Table 18: Virtex-II Pro 3-State Buffers

Device	3-State Buffers per Row	Total Number of 3-State Buffers
XC2VP2	44	704
XC2VP4	44	1,504
XC2VP7	68	2,464
XC2VP20	92	4,640
XC2VPX20	92	4,896
XC2VP30	92	6,848
XC2VP40	116	9,696
XC2VP50	140	11,808
XC2VP70	164	16,544
XC2VPX70	164	16,544
XC2VP100	188	22,048



DS031_09_032700

Figure 46: 3-State Buffer Connection to Horizontal Lines

The DCM has the following general control signals:

- RST input pin: resets the entire DCM
- LOCKED output pin: asserted High when all enabled DCM circuits have locked.
- STATUS output pins (active High): shown in [Table 27](#).

Table 27: DCM Status Pins

Status Pin	Function
0	Phase Shift Overflow
1	CLKIN Stopped
2	CLKFX Stopped
3	N/A
4	N/A
5	N/A
6	N/A
7	N/A

Clock De-skew

The DCM de-skews the output clocks relative to the input clock by automatically adjusting a digital delay line. Additional delay is introduced so that clock edges arrive at internal registers and block RAMs simultaneously with the clock edges arriving at the input clock pad. Alternatively, external clocks, which are also de-skewed relative to the input clock, can be generated for board-level routing. All DCM output clocks are phase-aligned to CLK0 and, therefore, are also phase-aligned to the input clock.

To achieve clock de-skew, connect the CLKFB input to CLK0. Note that CLKFB must always be connected, unless only the CLKFX or CLKFX180 outputs are used and de-skew is not required.

Frequency Synthesis

The DCM provides flexible methods for generating new clock frequencies. Each method has a different operating frequency range and different AC characteristics. The CLK2X and CLK2X180 outputs double the clock frequency. The CLKDV output creates divided output clocks with division options of 1.5, 2, 2.5, 3, 3.5, 4, 4.5, 5, 5.5, 6, 6.5, 7, 7.5, 8, 9, 10, 11, 12, 13, 14, 15, and 16.

The CLKFX and CLKFX180 outputs can be used to produce clocks at the following frequency:

$$\text{FREQ}_{\text{CLKFX}} = (M/D) \cdot \text{FREQ}_{\text{CLKIN}}$$

where M and D are two integers. Specifications for M and D are provided under **DCM Timing Parameters** in [Virtex-II Pro and Virtex-II Pro X Platform FPGAs: DC and Switching Characteristics](#). By default, $M = 4$ and $D = 1$,

which results in a clock output frequency four times faster than the clock input frequency (CLKIN).

CLK2X180 is phase shifted 180 degrees relative to CLK2X. CLKFX180 is phase shifted 180 degrees relative to CLKFX. All frequency synthesis outputs automatically have 50/50 duty cycles, with the exception of the CLKDV output when performing a non-integer divide in high-frequency mode. See [Table 28](#) for more details.

Note that CLK2X and CLK2X180 are not available in high-frequency mode.

Table 28: CLKDV Duty Cycle for Non-integer Divides

CLKDV_DIVIDE	Duty Cycle
1.5	1/3
2.5	2/5
3.5	3/7
4.5	4/9
5.5	5/11
6.5	6/13
7.5	7/15

Phase Shifting

The DCM provides additional control over clock skew through either coarse or fine-grained phase shifting. The CLK0, CLK90, CLK180, and CLK270 outputs are each phase shifted by $\frac{1}{4}$ of the input clock period relative to each other, providing coarse phase control. Note that CLK90 and CLK270 are not available in high-frequency mode.

Fine-phase adjustment affects all nine DCM output clocks. When activated, the phase shift between the rising edges of CLKIN and CLKFB is a specified fraction of the input clock period.

In variable mode, the PHASE_SHIFT value can also be dynamically incremented or decremented as determined by PSINCDEC synchronously to PSCLK, when the PSEN input is active. [Figure 63](#) illustrates the effects of fine-phase shifting. For more information on DCM features, see the [Virtex-II Pro Platform FPGA User Guide](#).

[Table 29](#) lists fine-phase shifting control pins, when used in variable mode.

Table 29: Fine Phase Shifting Control Pins

Control Pin	Direction	Function
PSINCDEC	In	Increment or decrement
PSEN	In	Enable $\pm$ phase shift
PSCLK	In	Clock for phase shift
PSDONE	Out	Active when completed



Virtex-II Pro and Virtex-II Pro X Platform FPGAs: DC and Switching Characteristics

DS083 (v5.0) June 21, 2011

Product Specification

Virtex-II Pro⁽¹⁾ Electrical Characteristics

Virtex™-II Pro devices are provided in -7, -6, and -5 speed grades, with -7 having the highest performance.

Virtex-II Pro DC and AC characteristics are specified for both commercial and industrial grades. Except the operating temperature range or unless otherwise noted, all the DC and AC electrical parameters are the same for a particular speed grade (that is, the timing characteristics of a -6 speed grade industrial device are the same as for a -6 speed grade

commercial device). However, only selected speed grades and/or devices might be available in the industrial range.

All supply voltage and junction temperature specifications are representative of worst-case conditions. The parameters included are common to popular designs and typical applications. Contact Xilinx for design considerations requiring more detailed information.

All specifications are subject to change without notice.

Virtex-II Pro DC Characteristics

Table 1: Absolute Maximum Ratings

Symbol	Description ⁽¹⁾		Virtex-II Pro X	Virtex-II Pro	Units
V _{CCINT}	Internal supply voltage relative to GND		-0.5 to 1.6		V
V _{CCAUX}	Auxiliary supply voltage relative to GND		-0.5 to 3.0		V
V _{CCO}	Output drivers supply voltage relative to GND		-0.5 to 3.75		V
V _{BATT}	Key memory battery backup supply		-0.5 to 4.05		V
V _{REF}	Input reference voltage		-0.3 to 3.75		V
V _{IN}	3.3V I/O input voltage relative to GND (user and dedicated I/Os)		-0.3 to 4.05 ⁽³⁾		V
	2.5V or below I/O input voltage relative to GND (user and dedicated I/Os)		-0.5 to V _{CCO} + 0.5		V
V _{TS}	Voltage applied to 3-state 3.3V output (user and dedicated I/Os)		-0.3 to 4.05 ⁽³⁾		V
	Voltage applied to 3-state 2.5V or below output (user and dedicated I/Os)		-0.5 to V _{CCO} + 0.5		V
AVCCAUXRX	Receive auxiliary supply voltage relative to GNDA (analog ground)		-0.5 to 2.0	-0.5 to 3.0	V
AVCCAUTX	Transmit auxiliary supply voltage relative to GNDA (analog ground)		-0.5 to 3.0	-0.5 to 3.0	V
V _{TRX}	Terminal receive supply voltage relative to GND		-0.5 to 3.0	-0.5 to 3.0	V
V _{TTX}	Terminal transmit supply voltage relative to GND		-0.5 to 1.6	-0.5 to 3.0	V
T _{STG}	Storage temperature (ambient)		-65 to +150		°C
T _{SOL}	Maximum soldering temperature ⁽²⁾	All regular FG/FF flip-chip packages	+220		°C
		Pb-free FGG256 wire-bond package	N/A	+260	°C
		Pb-free FGG456 and FGG676 wire-bond packages	N/A	+250	°C
T _J	Maximum junction temperature ⁽²⁾		+125		°C

Notes:

1. Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.
2. For soldering guidelines and thermal considerations, see the [Device Packaging and Thermal Characteristics Guide](#) information on the Xilinx website.
3. 3.3V I/O Absolute Maximum limit applied to DC and AC signals. Refer to [XAPP659](#) for more details.

1. Unless otherwise noted, "Virtex-II Pro" refers to members of the Virtex-II Pro and/or Virtex-II Pro X families.

IOB Input Switching Characteristics Standard Adjustments

Table 36 gives all standard-specific data input delay adjustments.

Table 36: IOB Input Switching Characteristics Standard Adjustments

Description	IOSTANDARD Attribute	Timing Parameter	Speed Grade			Units
			-7	-6	-5	
LVTTL (Low-Voltage Transistor-Transistor Logic)	LVTTL	$T_{ILVTTTL}$	0.07	0.08	0.09	ns
LVC MOS (Low-Voltage CMOS), 3.3V	LVC MOS33	$T_{ILVCMOS33}$	0.04	0.05	0.05	ns
LVC MOS, 2.5V	LVC MOS25	$T_{ILVCMOS25}$	0.00	0.00	0.00	ns
LVC MOS, 1.8V	LVC MOS18	$T_{ILVCMOS18}$	0.29	0.33	0.36	ns
LVC MOS, 1.5V	LVC MOS15	$T_{ILVCMOS15}$	0.36	0.41	0.45	ns
LVDS (Low-Voltage Differential Signaling), 2.5V	LVDS_25	T_{ILVDS_25}	0.31	0.36	0.40	ns
LVDSEXT (LVDS Extended Mode), 2.5V	LVDSEXT_25	$T_{ILVDSEXT_25}$	0.33	0.37	0.41	ns
ULVDS (Ultra LVDS), 2.5V	ULVDS_25	T_{IULVDS_25}	0.31	0.36	0.40	ns
BLVDS (Bus LVDS), 2.5V	BLVDS_25	T_{IBLVDS_25}	0.00	0.00	0.00	ns
LDT (HyperTransport), 2.5V	LDT_25	$T_{ILD T_25}$	0.31	0.36	0.40	ns
LVPECL (Low-Voltage Positive Emitter-Coupled Logic), 2.5V	LVPECL_25	$T_{ILVPECL_25}$	0.69	0.80	0.88	ns
PCI (Peripheral Component Interface), 33 MHz, 3.3V	PCI33_3	T_{IPCI33_3}	0.14	0.16	0.18	ns
PCI, 66 MHz, 3.3V	PCI66_3	T_{IPCI66_3}	0.15	0.17	0.19	ns
PCI-X, 133 MHz, 3.3V	PCIX	T_{IPCIX}	0.12	0.13	0.15	ns
GTL (Gunning Transceiver Logic)	GTL	T_{IGTL}	0.59	0.68	0.74	ns
GTL Plus	GTLP	T_{IGTLP}	0.63	0.72	0.79	ns
HSTL (High-Speed Transceiver Logic), Class I	HSTL_I	T_{IHSTL_I}	0.59	0.68	0.75	ns
HSTL, Class II	HSTL_II	T_{IHSTL_II}	0.59	0.68	0.75	ns
HSTL, Class III	HSTL_III	T_{IHSTL_III}	0.57	0.66	0.72	ns
HSTL, Class IV	HSTL_IV	T_{IHSTL_IV}	0.58	0.67	0.74	ns
HSTL, Class I, 1.8V	HSTL_I_18	$T_{IHSTL_I_18}$	0.57	0.65	0.72	ns
HSTL, Class II, 1.8V	HSTL_II_18	$T_{IHSTL_II_18}$	0.55	0.63	0.69	ns
HSTL, Class III, 1.8V	HSTL_III_18	$T_{IHSTL_III_18}$	0.56	0.64	0.70	ns
HSTL, Class IV, 1.8V	HSTL_IV_18	$T_{IHSTL_IV_18}$	0.57	0.65	0.71	ns
SSTL (Stub Series Terminated Logic), Class I, 1.8V	SSTL18_I	$T_{ISSTL18_I}$	0.62	0.72	0.79	ns
SSTL, Class II, 1.8V	SSTL18_II	$T_{ISSTL18_II}$	0.64	0.73	0.81	ns
SSTL, Class I, 2.5V	SSTL2_I	T_{ISSTL2_I}	0.62	0.72	0.79	ns
SSTL, Class II, 2.5V	SSTL2_II	T_{ISSTL2_II}	0.64	0.73	0.81	ns
LVDCI (Low-Voltage Digitally Controlled Impedance), 3.3V	LVDCI_33	T_{ILVDCI_33}	-0.05	-0.05	-0.06	ns
LVDCI, 2.5V	LVDCI_25	T_{ILVDCI_25}	0.00	0.00	0.00	ns
LVDCI, 1.8V	LVDCI_18	T_{ILVDCI_18}	0.07	0.09	0.09	ns
LVDCI, 1.5V	LVDCI_15	T_{ILVDCI_15}	0.13	0.15	0.17	ns
LVDCI, 2.5V, Half-Impedance	LVDCI_DV2_25	$T_{ILVDCI_DV2_25}$	0.00	0.00	0.00	ns
LVDCI, 1.8V, Half-Impedance	LVDCI_DV2_18	$T_{ILVDCI_DV2_18}$	0.07	0.09	0.09	ns
LVDCI, 1.5V, Half-Impedance	LVDCI_DV2_15	$T_{ILVDCI_DV2_15}$	0.13	0.15	0.17	ns
HSLVDCI (High-Speed Low-Voltage DCI), 1.5V	HSLVDCI_15	$T_{IHSLVDCI_15}$	0.59	0.68	0.75	ns

I/O Standard Adjustment Measurement Methodology

Input Delay Measurements

Table 39 shows the test setup parameters used for measuring Input standard adjustments (see Table 36, page 25).

Table 39: Input Delay Measurement Methodology

Description	IOSTANDARD Attribute	$V_L^{(1,2)}$	$V_H^{(1,2)}$	$V_{MEAS}^{(1,4,5)}$	$V_{REF}^{(1,3,5)}$
LVTTTL (Low-Voltage Transistor-Transistor Logic)	LVTTTL	0	3.3	1.65	—
LVC MOS (Low-Voltage CMOS), 3.3V	LVC MOS33	0	3.3	1.65	—
LVC MOS, 2.5V	LVC MOS25	0	2.5	1.25	—
LVC MOS, 1.8V	LVC MOS18	0	1.8	0.9	—
LVC MOS, 1.5V	LVC MOS15	0	1.5	0.75	—
PCI (Peripheral Component Interface), 33 MHz, 3.3V	PCI33_3	Per PCI Specification			—
PCI, 66 MHz, 3.3V	PCI66_3	Per PCI Specification			—
PCI-X, 133 MHz, 3.3V	PCIX	Per PCI-X Specification			—
GTL (Gunning Transceiver Logic)	GTL	$V_{REF} - 0.2$	$V_{REF} + 0.2$	V_{REF}	0.80
GTL Plus	GTLP	$V_{REF} - 0.2$	$V_{REF} + 0.2$	V_{REF}	1.0
HSTL (High-Speed Transceiver Logic), Class I & II	HSTL_I, HSTL_II	$V_{REF} - 0.5$	$V_{REF} + 0.5$	V_{REF}	0.75
HSTL, Class III & IV	HSTL_III, HSTL_IV	$V_{REF} - 0.5$	$V_{REF} + 0.5$	V_{REF}	0.90
HSTL, Class I & II, 1.8V	HSTL_I_18, HSTL_II_18	$V_{REF} - 0.5$	$V_{REF} + 0.5$	V_{REF}	0.90
HSTL, Class III & IV, 1.8V	HSTL_III_18, HSTL_IV_18	$V_{REF} - 0.5$	$V_{REF} + 0.5$	V_{REF}	1.08
SSTL (Stub Terminated Tnschr Logic), Class I & II, 2.5V	SSTL2_I, SSTL2_II	$V_{REF} - 0.75$	$V_{REF} + 0.75$	V_{REF}	1.25
SSTL, Class I & II, 1.8V	SSTL18_I, SSTL18_II	$V_{REF} - 0.5$	$V_{REF} + 0.5$	V_{REF}	0.9
LVDS (Low-Voltage Differential Signaling), 2.5V	LVDS_25	$1.2 - 0.125$	$1.2 + 0.125$	1.2	
LVDSEXT (LVDS Extended Mode), 2.5V	LVDSEXT_25	$1.2 - 0.125$	$1.2 + 0.125$	1.2	
ULVDS (Ultra LVDS), 2.5V	ULVDS_25	$0.6 - 0.125$	$0.6 + 0.125$	0.6	
LDT (HyperTransport), 2.5V	LDT_25	$0.6 - 0.125$	$0.6 + 0.125$	0.6	
LVPECL (Low-Voltage Positive Emitter-Coupled Logic), 2.5V	LVPECL_25	$1.15 - 0.3$	$1.15 + 0.3$	1.15	

Notes:

1. Input delay measurement methodology parameters for LVDCI and HSLVDCI are the same as for LVC MOS standards of the same voltage. Parameters for all other DCI standards are the same as for the corresponding non-DCI standards.
2. Input waveform switches between V_L and V_H .
3. Measurements are made at typical, minimum, and maximum V_{REF} values. Reported delays reflect worst case of these measurements. V_{REF} values listed are typical. See [Virtex-II Pro Platform FPGA User Guide](#) for min/max specifications.
4. Input voltage level from which measurement starts.
5. Note that this is an input voltage reference that bears no relation to the V_{REF} / V_{MEAS} parameters found in IBIS models and/or noted in Figure 6.

Date	Version	Revision
12/05/03 (cont'd)	3.0 (cont'd)	- Non-speedsfile parameter values added or updated: Table 3: I_{BATT}. Table 4: For XC2VP100, I_{CCINTQ}, I_{CCOQ}, and I_{CCAUXQ}. Table 5: For XC2VP100, $I_{CCINTMIN}$. Table 17: T_{CPWL} and T_{CPWH}. Table 25: Added explanatory footnote to T_{RXLAT} (MGT receiver latency) max value. Table 57: Added Footnote (3) regarding use of CLKIN_DIVIDE_BY_2 attribute.
02/19/04	3.1	- Updated time and frequency parameters as per speedsfile v1.85. Table 2, Recommended Operating Conditions: Revised Footnotes (4) and (6). Table 4, Quiescent Supply Current: Added Footnote (1) and updated Typical parameters. Table 10, LVPECL DC Specifications: Added parameter values for Maximum Differential Input Voltage (LVPECL). Table 14, Register-to-Register Performance: Removed reference to a number of designs for which test data is no longer provided. Table 16, Processor Clocks Absolute AC Characteristics: Added Footnote (1) referring to XAPP755. - Added Table 41, Clock Distribution Switching Characteristics. - Revised section Configuration Timing, page 39 through page 41, and JTAG Test Access Port Switching Characteristics, page 42, with improved timing diagrams, parameter tables, and organization. Table 50, Master/Slave Serial Mode Timing Characteristics, and Table 51, SelectMAP Mode Write Timing Characteristics: Added parameter $F_{CC_STARTUP}$. Table 51, SelectMAP Mode Write Timing Characteristics: Broke out T_{SMDCC}/T_{SMCCD}, DATA[0:7] setup/hold time, by device, and added new parameter specifications for XC2VP70 and XC2VP100 devices. Table 57, Operating Frequency Ranges: Added callouts for existing Footnote (3) to the four CLKIN parameters. Added new Footnote (4) to the four CLKIN parameters. Added new Footnote (5) to CLK2X, CLK2X180. Added new Footnote (6) to CLK2X, CLK2X180; CLK0, CLK180; and CLKIN (using DLL outputs).
03/09/04	3.1.1	Recompiled for backward compatibility with Acrobat 4 and above. No content changes.
04/22/04	3.2	Table 2, Recommended Operating Conditions: Corrected VTTX/VTRX lower voltage limit from 1.8V to 1.6V. Table 5, Power-On Current for Virtex-II Pro Devices: Added Footnote (2) stating that listed I_{CCOMIN} values apply to the entire device (all banks). Table 40, Output Delay Measurement Methodology: Corrected V_{MEAS} for LVTTTL from 1.4V to 1.65V. Table 57, Operating Frequency Ranges: Corrected CLKOUT_FREQ_1X_LF_MAX and CLKIN_FREQ_DLL_LF_MAX for -7 devices from 210 MHz to 270 MHz. Table 65, Package Skew: Removed XC2VP40FF1517.
06/30/04	4.0	Merged in DS110-3 (Module 3 of Virtex-II Pro X data sheet). This merge added numerous previously unpublished RocketIO X MGT parameters. Specifications in this revision are from speedsfile v1.86 .

Table 8: FF672 — XC2VP2, XC2VP4, and XC2VP7

Bank	Pin Description	Pin Number	No Connects		
			XC2VP2	XC2VP4	XC2VP7
N/A	GND	R15			
N/A	GND	R16			
N/A	GND	R17			
N/A	GND	T11			
N/A	GND	T12			
N/A	GND	T13			
N/A	GND	T14			
N/A	GND	T15			
N/A	GND	T16			
N/A	GND	U10			
N/A	GND	U12			
N/A	GND	U13			
N/A	GND	U14			
N/A	GND	U15			
N/A	GND	U17			
N/A	GND	Y20			
N/A	GND	AA21			
N/A	GND	AB22			
N/A	GND	AC23			
N/A	GND	AD24			

Notes:

1. See [Table 4](#) for an explanation of the signals available on this pin.

Table 9: FF896 — XC2VP7, XC2VP20, XC2VPX20, and XC2VP30

Bank	Pin Description		Pin Number	No Connects		
	Virtex-II Pro devices	XC2VPX20 (if Different)		XC2VP7	XC2VP20, XC2VPX20	XC2VP30
N/A	M0		AD24			
N/A	M1		AC24			
N/A	M2		AC23			
N/A	TCK		G7			
N/A	TDI		F26			
N/A	TDO		F5			
N/A	TMS		H8			
N/A	PWRDWN_B		AD7			
N/A	HSWAP_EN		H23			
N/A	RSVD		D6			
N/A	VBATT		H7			
N/A	DXP		H24			
N/A	DXN		D25			
N/A	AVCCAUXTX4		B26			
N/A	VTTXPAD4		B27			
N/A	TXNPAD4		A27			
N/A	TXPPAD4		A26			
N/A	GND4		C25			
N/A	RXPPAD4		A25			
N/A	RXNPAD4		A24			
N/A	VTRXPAD4		B25			
N/A	AVCCAUXXRX4		B24			
N/A	AVCCAUXTX6		B19			
N/A	VTTXPAD6		B20			
N/A	TXNPAD6		A20			
N/A	TXPPAD6		A19			
N/A	GND6		C19			
N/A	RXPPAD6		A18			
N/A	RXNPAD6		A17			
N/A	VTRXPAD6		B18			
N/A	AVCCAUXXRX6		B17			
N/A	AVCCAUXTX7		B13			
N/A	VTTXPAD7		B14			
N/A	TXNPAD7		A14			
N/A	TXPPAD7		A13			
N/A	GND7		C12			

Table 10: FF1152 — XC2VP20, XC2VP30, XC2VP40, and XC2VP50

Bank	Pin Description	Pin Number	No Connects			
			XC2VP20	XC2VP30	XC2VP40	XC2VP50
N/A	TXPPAD9	A8				
N/A	GND A9	C8				
N/A	RXPPAD9	A7				
N/A	RXNPAD9	A6				
N/A	VTRXPAD9	B7				
N/A	AVCCAUXRX9	B6				
N/A	AVCCAUXTX11	B4	NC	NC		
N/A	VTTXPAD11	B5	NC	NC		
N/A	TXNPAD11	A5	NC	NC		
N/A	TXPPAD11	A4	NC	NC		
N/A	GND A11	C5	NC	NC		
N/A	RXPPAD11	A3	NC	NC		
N/A	RXNPAD11	A2	NC	NC		
N/A	VTRXPAD11	B3	NC	NC		
N/A	AVCCAUXRX11	B2	NC	NC		
N/A	AVCCAUXRX14	AN2	NC	NC		
N/A	VTRXPAD14	AN3	NC	NC		
N/A	RXNPAD14	AP2	NC	NC		
N/A	RXPPAD14	AP3	NC	NC		
N/A	GND A14	AM5	NC	NC		
N/A	TXPPAD14	AP4	NC	NC		
N/A	TXNPAD14	AP5	NC	NC		
N/A	VTTXPAD14	AN5	NC	NC		
N/A	AVCCAUXTX14	AN4	NC	NC		
N/A	AVCCAUXRX16	AN6				
N/A	VTRXPAD16	AN7				
N/A	RXNPAD16	AP6				
N/A	RXPPAD16	AP7				
N/A	GND A16	AM8				
N/A	TXPPAD16	AP8				
N/A	TXNPAD16	AP9				
N/A	VTTXPAD16	AN9				
N/A	AVCCAUXTX16	AN8				
N/A	AVCCAUXRX17	AN10	NC	NC	NC	
N/A	VTRXPAD17	AN11	NC	NC	NC	
N/A	RXNPAD17	AP10	NC	NC	NC	
N/A	RXPPAD17	AP11	NC	NC	NC	
N/A	GND A17	AM12	NC	NC	NC	

Table 11: FF1148 — XC2VP40 and XC2VP50

Bank	Pin Description	Pin Number	No Connects	
			XC2VP40	XC2VP50
0	IO_L43N_0	B22		
0	IO_L43P_0	C22		
0	IO_L44N_0	K21		
0	IO_L44P_0	L21		
0	IO_L45N_0	G21		
0	IO_L45P_0/VREF_0	H21		
0	IO_L46N_0	E21		
0	IO_L46P_0	F21		
0	IO_L47N_0	K20		
0	IO_L47P_0	L20		
0	IO_L48N_0	C21		
0	IO_L48P_0	D21		
0	IO_L49N_0	A21		
0	IO_L49P_0	B21		
0	IO_L50_0/No_Pair	G20		
0	IO_L53_0/No_Pair	H19		
0	IO_L54N_0	E20		
0	IO_L54P_0	F20		
0	IO_L55N_0	C20		
0	IO_L55P_0	D19		
0	IO_L56N_0	K19		
0	IO_L56P_0	L19		
0	IO_L57N_0	A20		
0	IO_L57P_0/VREF_0	B20		
0	IO_L66N_0	F19	NC	
0	IO_L66P_0/VREF_0	G19	NC	
0	IO_L67N_0	B19		
0	IO_L67P_0	C19		
0	IO_L68N_0	H18		
0	IO_L68P_0	J18		
0	IO_L69N_0	F18		
0	IO_L69P_0/VREF_0	G18		
0	IO_L73N_0	D18		
0	IO_L73P_0	E18		
0	IO_L74N_0/GCLK7P	K18		
0	IO_L74P_0/GCLK6S	L18		
0	IO_L75N_0/GCLK5P	B18		
0	IO_L75P_0/GCLK4S	C18		

Table 11: FF1148 — XC2VP40 and XC2VP50

Bank	Pin Description	Pin Number	No Connects	
			XC2VP40	XC2VP50
2	IO_L59P_2	U11		
2	IO_L60N_2	R1		
2	IO_L60P_2	R2		
2	IO_L85N_2	T3		
2	IO_L85P_2	T4		
2	IO_L86N_2	U8		
2	IO_L86P_2	U9		
2	IO_L87N_2	U2		
2	IO_L87P_2	T2		
2	IO_L88N_2/VREF_2	U4		
2	IO_L88P_2	U5		
2	IO_L89N_2	U6		
2	IO_L89P_2	U7		
2	IO_L90N_2	V3		
2	IO_L90P_2	U3		
3	IO_L90N_3	V6		
3	IO_L90P_3	V7		
3	IO_L89N_3	V10		
3	IO_L89P_3	V11		
3	IO_L88N_3	V4		
3	IO_L88P_3	V5		
3	IO_L87N_3/VREF_3	V2		
3	IO_L87P_3	W2		
3	IO_L86N_3	V8		
3	IO_L86P_3	V9		
3	IO_L85N_3	W6		
3	IO_L85P_3	W7		
3	IO_L60N_3	W3		
3	IO_L60P_3	W4		
3	IO_L59N_3	W10		
3	IO_L59P_3	W11		
3	IO_L58N_3	Y5		
3	IO_L58P_3	Y6		
3	IO_L57N_3/VREF_3	Y3		
3	IO_L57P_3	AA3		
3	IO_L56N_3	W8		
3	IO_L56P_3	Y7		

Table 12: FF1517 — XC2VP50 and XC2VP70

Bank	Pin Description	Pin Number	No Connects	
			XC2VP50	XC2VP70
7	IO_L43N_7	R37		
7	IO_L42P_7	R34		
7	IO_L42N_7	R35		
7	IO_L41P_7	U28		
7	IO_L41N_7	T28		
7	IO_L40P_7	R32		
7	IO_L40N_7/VREF_7	R33		
7	IO_L39P_7	P38		
7	IO_L39N_7	P39		
7	IO_L38P_7	T29		
7	IO_L38N_7	T30		
7	IO_L37P_7	N37		
7	IO_L37N_7	P37		
7	IO_L36P_7	P35		
7	IO_L36N_7	P36		
7	IO_L35P_7	T27		
7	IO_L35N_7	R27		
7	IO_L34P_7	P33		
7	IO_L34N_7/VREF_7	P34		
7	IO_L33P_7	N38		
7	IO_L33N_7	N39		
7	IO_L32P_7	R28		
7	IO_L32N_7	R29		
7	IO_L31P_7	N35		
7	IO_L31N_7	M36		
7	IO_L30P_7	N33		
7	IO_L30N_7	N34		
7	IO_L29P_7	R30		
7	IO_L29N_7	R31		
7	IO_L28P_7	M37		
7	IO_L28N_7/VREF_7	M38		
7	IO_L27P_7	M33		
7	IO_L27N_7	M34		
7	IO_L26P_7	P28		
7	IO_L26N_7	P29		
7	IO_L25P_7	L38		
7	IO_L25N_7	L39		
7	IO_L24P_7	L36		

Table 12: FF1517 — XC2VP50 and XC2VP70

Bank	Pin Description	Pin Number	No Connects	
			XC2VP50	XC2VP70
N/A	TXNPAD11	A7		
N/A	TXPPAD11	A6		
N/A	GND A11	C6		
N/A	RXPPAD11	A5		
N/A	RXNPAD11	A4		
N/A	VTRXPAD11	B5		
N/A	AVCCAUXRX11	B4		
N/A	AVCCAUXRX14	AV4		
N/A	VTRXPAD14	AV5		
N/A	RXNPAD14	AW4		
N/A	RXPPAD14	AW5		
N/A	GND A14	AU6		
N/A	TXPPAD14	AW6		
N/A	TXNPAD14	AW7		
N/A	VTTXPAD14	AV7		
N/A	AVCCAUXTX14	AV6		
N/A	AVCCAUXRX16	AV8		
N/A	VTRXPAD16	AV9		
N/A	RXNPAD16	AW8		
N/A	RXPPAD16	AW9		
N/A	GND A16	AU9		
N/A	TXPPAD16	AW10		
N/A	TXNPAD16	AW11		
N/A	VTTXPAD16	AV11		
N/A	AVCCAUXTX16	AV10		
N/A	AVCCAUXRX17	AV12		
N/A	VTRXPAD17	AV13		
N/A	RXNPAD17	AW12		
N/A	RXPPAD17	AW13		
N/A	GND A17	AU13		
N/A	TXPPAD17	AW14		
N/A	TXNPAD17	AW15		
N/A	VTTXPAD17	AV15		
N/A	AVCCAUXTX17	AV14		
N/A	AVCCAUXRX18	AV16		
N/A	VTRXPAD18	AV17		
N/A	RXNPAD18	AW16		
N/A	RXPPAD18	AW17		

Table 13: FF1704 — XC2VP70, XC2VPX70, and XC2VP100

Bank	Pin Description		Pin Number	No Connects	
	Virtex-II Pro Devices	XC2VPX70 (if Different)		XC2VP70, XC2VPX70	XC2VP100
N/A	GND		E22		
N/A	GND		E21		
N/A	GND		E5		
N/A	GND		D39		
N/A	GND		D32		
N/A	GND		D28		
N/A	GND		D15		
N/A	GND		D11		
N/A	GND		D4		
N/A	GND		C42		
N/A	GND		C41		
N/A	GND		C40		
N/A	GND		C3		
N/A	GND		C2		
N/A	GND		C1		
N/A	GND		B42		
N/A	GND		B1		
N/A	GND		N14		
N/A	GND		N29		
N/A	GND		AK14		
N/A	GND		AK29		
N/A	GND		P13		
N/A	GND		P30		
N/A	GND		AJ13		
N/A	GND		AJ30		

Notes:

1. See [Table 4](#) for an explanation of the signals available on this pin.

Table 14: FF1696 — XC2VP100

Bank	Pin Description	Pin Number	No Connects
			XC2VP100
6	IO_L15P_6	AP39	
6	IO_L15N_6/VREF_6	AP40	
6	IO_L16P_6	AP36	
6	IO_L16N_6	AP37	
6	IO_L17P_6	AH31	
6	IO_L17N_6	AG31	
6	IO_L18P_6	AN41	
6	IO_L18N_6	AN42	
6	IO_L19P_6	AN40	
6	IO_L19N_6	AM40	
6	IO_L20P_6	AG34	
6	IO_L20N_6	AG35	
6	IO_L21P_6	AN37	
6	IO_L21N_6/VREF_6	AN38	
6	IO_L22P_6	AN36	
6	IO_L22N_6	AM36	
6	IO_L23P_6	AG32	
6	IO_L23N_6	AG33	
6	IO_L24P_6	AM41	
6	IO_L24N_6	AM42	
6	IO_L25P_6	AM38	
6	IO_L25N_6	AM39	
6	IO_L26P_6	AF35	
6	IO_L26N_6	AF36	
6	IO_L27P_6	AM37	
6	IO_L27N_6/VREF_6	AL36	
6	IO_L28P_6	AL41	
6	IO_L28N_6	AK41	
6	IO_L29P_6	AF32	
6	IO_L29N_6	AF33	
6	IO_L30P_6	AL39	
6	IO_L30N_6	AL40	
6	IO_L31P_6	AL37	
6	IO_L31N_6	AL38	
6	IO_L32P_6	AF31	
6	IO_L32N_6	AE31	
6	IO_L33P_6	AK39	

Table 14: FF1696 — XC2VP100

Bank	Pin Description	Pin Number	No Connects
			XC2VP100
6	IO_L33N_6/VREF_6	AK40	
6	IO_L34P_6	AK36	
6	IO_L34N_6	AK37	
6	IO_L35P_6	AE36	
6	IO_L35N_6	AE37	
6	IO_L36P_6	AJ41	
6	IO_L36N_6	AJ42	
6	IO_L37P_6	AJ40	
6	IO_L37N_6	AH40	
6	IO_L38P_6	AE34	
6	IO_L38N_6	AE35	
6	IO_L39P_6	AJ38	
6	IO_L39N_6/VREF_6	AH37	
6	IO_L40P_6	AJ36	
6	IO_L40N_6	AJ37	
6	IO_L41P_6	AE32	
6	IO_L41N_6	AE33	
6	IO_L42P_6	AH41	
6	IO_L42N_6	AH42	
6	IO_L43P_6	AH38	
6	IO_L43N_6	AH39	
6	IO_L44P_6	AD36	
6	IO_L44N_6	AC35	
6	IO_L45P_6	AH36	
6	IO_L45N_6/VREF_6	AG36	
6	IO_L46P_6	AG41	
6	IO_L46N_6	AG42	
6	IO_L47P_6	AD34	
6	IO_L47N_6	AC33	
6	IO_L48P_6	AG40	
6	IO_L48N_6	AF39	
6	IO_L49P_6	AG38	
6	IO_L49N_6	AG39	
6	IO_L50P_6	AD32	
6	IO_L50N_6	AD33	
6	IO_L51P_6	AG37	
6	IO_L51N_6/VREF_6	AF37	